

Proposal For Graphics And Visualization Project

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1 Problem Statement

Feature identification and matching through persistence diagram and overview visualization of the time step data set.

2 List of Features/Algorithms

1. Forming persistence diagram for every time step by finding critical points. We'll be using TTK(Topology Tool Kit) and ParaView for computation of persistence diagrams.
2. For every cross product of persistence pairs between 2 persistence diagrams of the consecutive time steps we compute a distance. The distance metric we are going to use is Waaserstein's distance $d(p_i, p_{i+1})$.
3. We'll be finding the matching pairs of 2 consecutive persistence diagrams using Kuhn Munkres algorithm. It finds the optimal matching function for a persistence pair by minimizing the total distance $\sum_i d(p_i, M(p_i))$ where p_i is the pair for the persistence diagram for the i^{th} step and $M(p_i)$ is matching for it.

References

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